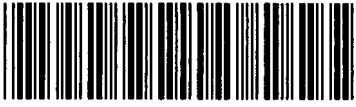


<b>Search Notes</b>  	<b>Application/Control No.</b>  10705300	<b>Applicant(s)/Patent Under Reexamination</b>  PARMA ET AL.
	<b>Examiner</b>  Shin, Dana	<b>Art Unit</b>  1635

SEARCHED			
Class	Subclass	Date	Examiner
514	44	6-1-07	DS
536	24.5	6-1-07	DS

SEARCH NOTES		
Search Notes	Date	Examiner
EAST - search strategy attached	6-1-07	DS
Medline, Embase, Scisearch, CA, Biosis - search strategy attached	6-1-07	DS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner